

Data Sheet December 1992 File Number 3338

CMOS Presettable Up/Down Counters

CD4510BMS Presettable BCD Up/Down Counter and the CD4516BMS Presettable Binary Up/Down counter consist of four synchronously clocked D-type flip-flops (with a gating structure to provide T-type flip-flop capability) connected as counters. These counters can be cleared by a high level on the RESET line, and can be preset to any binary number present on the jam inputs by a high level on the PRESET ENABLE line. The CD4510BMS will count out of non-BCD counter states in a maximum of two clock pulses in the up mode, and a maximum of four clock pulses in the down mode.

If the CARRY IN input is held low, the counter advances up or down on each positive-going clock transition. Synchronous cascading is accomplished by connecting all clock inputs in parallel and connecting the CARRY OUT of a less significant stage to the CARRY IN of a more significant stage.

The CD4510BMS and CD4516BMS can be cascaded in the ripple mode by connecting the CARRY OUT to the clock of the next stage. If the UP/DOWN input changes during a terminal count, the CARRY OUT must be gated with the clock, and the UP/DOWN input must change while the clock is high. This method provides a clean clock signal to the subsequent counting stage. (See Figures 13, 14.)

These devices are similar to types MC14510 and MC14516.

The CD4510BMS and CD4516BMS are supplied in these 16-lead outline packages:

Braze Seal DIP *H4W †H45 Frit Seal DIP *FBF †H1F

Ceramic Flatpack H6W

Features

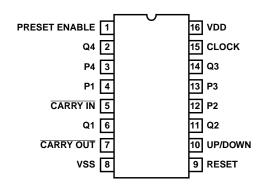
- · High Voltage Types (20V Rating)
- CD4510BMS BCD Type
- CD4516BMS Binary Type
- Medium Speed Operation
 - fCL = 8MHz Typ. at 10V
- Synchronous Internal Carry Propagation
- Reset and Preset Capability
- 100% Tested for Quiescent Current at 20V
- 5V, 10V and 15V Parametric Ratings
- Standardized Symmetrical Output Characteristics
- Maximum Input Current of 1μA at 18V Over Full Package Temperature Range; 100nA at 18V and +25°C
- Noise Margin (Over Full Package/Temperature Range)
 - 1V at VDD = 5V
 - 2V at VDD = 10V
 - 2.5V at VDD = 15V
- Meets All Requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"

Applications

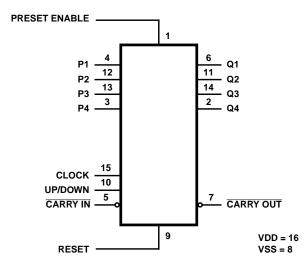
- Up/Down Difference Counting
- Multistage Synchronous Counting
- Multistage Ripple Counting
- Synchronous Frequency Dividers

Pinout

CD4510BMS, CD4516BMS TOP VIEW



Functional Diagram



Absolute Maximum Ratings

| DC Supply Voltage Range, (VDD)0.5V to +20V (Voltage Referenced to VSS Terminals) |
|--|
| , |
| Input Voltage Range, All Inputs0.5V to VDD +0.5V |
| DC Input Current, Any One Input |
| Operating Temperature Range55°C to +125°C |
| Package Types D, F, K, H |
| Storage Temperature Range (TSTG)65°C to +150°C |
| Lead Temperature (During Soldering) +265°C |
| At Distance 1/16 \pm 1/32 Inch (1.59mm \pm 0.79mm) from case for |
| 10s Maximum |

Reliability Information

| Thermal Resistance | θ_{ja} | θ_{jc} |
|---|---------------|---------------------------|
| Ceramic DIP and FRIT Package | 80°C/W | 20°C/W |
| Flatpack Package | 70°C/W | 20°C/W |
| Maximum Package Power Dissipation (PD | | |
| For TA = -55°C to +100°C (Package Type | | |
| For TA = +100°C to +125°C (Package 1 | Type D, F, K) | Derate |
| Linear | ity at 12mW | ¹ /OC to 200mW |
| Device Dissipation per Output Transistor. | | 100mW |
| For TA = Full Package Temperature Rar | nge (All Pac | kage Types) |
| Junction Temperature | | +175 ⁰ C |

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | GROUP A | | | LIM | IITS | |
|--------------------------------|--------|-----------------------------------|---------------|-----------|----------------------|-------|-------|-------|
| PARAMETER | SYMBOL | CONDITIONS (| NOTE 1) | SUBGROUPS | TEMPERATURE | MIN | MAX | UNITS |
| Supply Current | IDD | VDD = 20V, VIN = VDI | O or GND | 1 | +25 ^o C | - | 10 | μΑ |
| | | | | 2 | +125 ^o C | - | 1000 | μΑ |
| | | VDD = 18V, VIN = VDI | O or GND | 3 | -55 ⁰ C | - | 10 | μΑ |
| Input Leakage Current | IIL | VIN = VDD or GND | VDD = 20 | 1 | +25 ^o C | -100 | - | nA |
| | | | | 2 | +125 ^o C | -1000 | - | nA |
| | | | VDD = 18V | 3 | -55 ⁰ C | -100 | - | nA |
| Input Leakage Current | IIH | VIN = VDD or GND | VDD = 20 | 1 | +25 ^o C | - | 100 | nA |
| | | | | 2 | +125 ^o C | - | 1000 | nA |
| | | | VDD = 18V | 3 | -55 ⁰ C | - | 100 | nA |
| Output Voltage | VOL15 | VDD = 15V, No Load | • | 1, 2, 3 | +25°C, +125°C, -55°C | - | 50 | mV |
| Output Voltage | VOH15 | VDD = 15V, No Load (| Note 3) | 1, 2, 3 | +25°C, +125°C, -55°C | 14.95 | - | V |
| Output Current (Sink) | IOL5 | VDD = 5V, VOUT = 0.4 | 4V | 1 | +25 ^o C | 0.53 | - | mA |
| Output Current (Sink) | IOL10 | VDD = 10V, VOUT = 0 | .5V | 1 | +25 ^o C | 1.4 | - | mA |
| Output Current (Sink) | IOL15 | VDD = 15V, VOUT = 1 | .5V | 1 | +25 ^o C | 3.5 | - | mA |
| Output Current (Source) | IOH5A | VDD = 5V, VOUT = 4.6 | 6V | 1 | +25 ^o C | - | -0.53 | mA |
| Output Current (Source) | IOH5B | VDD = 5V, VOUT = 2.5 | 5V | 1 | +25 ^o C | - | -1.8 | mA |
| Output Current (Source) | IOH10 | VDD = 10V, VOUT = 9 | .5V | 1 | +25 ^o C | - | -1.4 | mA |
| Output Current (Source) | IOH15 | VDD = 15V, VOUT = 1 | 3.5V | 1 | +25 ^o C | - | -3.5 | mA |
| N Threshold Voltage | VNTH | VDD = 10V, ISS = -10 | ιA | 1 | +25 ^o C | -2.8 | -0.7 | V |
| P Threshold Voltage | VPTH | VSS = 0V, IDD = 10μA | 1 | 1 | +25 ^o C | 0.7 | 2.8 | V |
| Functional | F | VDD = 2.8V, VIN = VD | D or GND | 7 | +25 ^o C | VOH > | VOL < | V |
| | | VDD = 20V, VIN = VDI | O or GND | 7 | +25 ^o C | VDD/2 | VDD/2 | |
| | | VDD = 18V, VIN = VDI | O or GND | 8A | +125 ^o C | | | i |
| | | VDD = 3V, VIN = VDD | or GND | 8B | -55 ⁰ C | | | |
| Input Voltage Low (Note 2) | VIL | VDD = 5V, VOH > 4.5V, VOL < 0.5V | | 1, 2, 3 | +25°C, +125°C, -55°C | - | 1.5 | V |
| Input Voltage High (Note 2) | VIH | VDD = 5V, VOH > 4.5\ | /, VOL < 0.5V | 1, 2, 3 | +25°C, +125°C, -55°C | 3.5 | - | V |
| Input Voltage Low (Note 2) | VIL | VDD = 15V, VOH > 13 VOL < 1.5V | .5V, | 1, 2, 3 | +25°C, +125°C, -55°C | - | 4 | V |
| Input Voltage High (Note 2) | VIH | VDD = 15V, VOH > 13 VOL < 1.5V | .5V, | 1, 2, 3 | +25°C, +125°C, -55°C | 11 | - | V |

NOTES: 1. All voltages referenced to device GND, 100% testing being im- 3. For accuracy, voltage is measured differentially to VDD. Limit is plemented.

^{0.050}V max.

^{2.} Go/No Go test with limits applied to inputs.

TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | | | LIM | | | | | |
|---------------------------------|--------|----------------------------|-----------|---|----------------------------|-----|--------------------|---|-----|----|
| PARAMETER | SYMBOL | CONDITIONS (NOTE 1, 2) | SUBGROUPS | TEMPERATURE | MIN | MAX | UNITS | | | |
| Propagation Delay | TPHL1 | VDD = 5V, VIN = VDD or GND | 9 | +25 ⁰ C | - | 400 | ns | | | |
| Clock to Q Output | TPLH1 | | 10, 11 | +125 ^o C, -55 ^o C | - | 540 | ns | | | |
| Propagation Delay | TPHL2 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 420 | ns | | | |
| Preset or Reset to Q | TPLH2 | | 10, 11 | +125 ⁰ C, -55 ⁰ C | - | 567 | ns | | | |
| Propagation Delay | TPHL3 | VDD = 5V, VIN = VDD or GND | 9 | +25 ⁰ C | - | 480 | ns | | | |
| Clock to Carry Out | TPLH3 | | 10, 11 | +125°C, -55°C | - | 648 | ns | | | |
| Propagation Delay | TPHL4 | | | | VDD = 5V, VIN = VDD or GND | 9 | +25 ⁰ C | - | 250 | ns |
| Carry In to Carry Out | TPLH4 | | 10, 11 | +125 ^o C, -55 ^o C | - | 338 | ns | | | |
| Propagation Delay | TPHL5 | VDD = 5V, VIN = VDD or GND | 9 | +25°C | - | 640 | ns | | | |
| Preset or Reset to Carry Out | TPLH5 | (Note 3) | 10, 11 | +125 ⁰ C, -55 ⁰ C | - | 864 | ns | | | |
| Transition Time | TTHL | VDD = 5V, VIN = VDD or GND | 9 | +25 ^o C | - | 200 | ns | | | |
| TTLH | | | 10, 11 | +125 ^o C, -55 ^o C | - | 270 | ns | | | |
| Maximum Clock Input Fre- | FCL | VDD = 5V, VIN = VDD or GND | 9 | +25 ^o C | 2 | - | MHz | | | |
| quency | | | 10, 11 | +125°C, -55°C | 1.48 | - | MHz | | | |

NOTES:

- 1. CL = 50pF, RL = 200K, Input TR, TF < 20ns.
- 2. -55°C and +125°C limits guaranteed, 100% testing being implemented.
- 3. Reset to Carry Out (TPLH) only.

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | | | LIN | IITS | |
|-------------------------|--------|-----------------------------|-------|--------------------------|------|-------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | TEMPERATURE | MIN | MAX | UNITS |
| Supply Current | IDD | VDD = 5V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 5 | μΑ |
| | | | | +125°C | - | 150 | μΑ |
| | | VDD = 10V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 10 | μΑ |
| | | | | +125 ^o C | - | 300 | μΑ |
| | | VDD = 15V, VIN = VDD or GND | 1, 2 | -55°C, +25°C | - | 10 | μΑ |
| | | | | +125 ^o C | - | 600 | μΑ |
| Output Voltage | VOL | VDD = 5V, No Load | 1, 2 | +25°C, +125°C, - 55°C | - | 50 | mV |
| Output Voltage | VOL | VDD = 10V, No Load | 1, 2 | +25°C, +125°C, - 55°C | - | 50 | mV |
| Output Voltage | VOH | VDD = 5V, No Load | 1, 2 | +25°C, +125°C, - 55°C | 4.95 | - | V |
| Output Voltage | VOH | VDD = 10V, No Load | 1, 2 | +25°C, +125°C, - 55°C | 9.95 | - | V |
| Output Current (Sink) | IOL5 | VDD = 5V, VOUT = 0.4V | 1, 2 | +125 ⁰ C | 0.36 | - | mA |
| | | | | -55°C | 0.64 | - | mA |
| Output Current (Sink) | IOL10 | VDD = 10V, VOUT = 0.5V | 1, 2 | +125 ⁰ C | 0.9 | - | mA |
| | | | | -55 ^o C | 1.6 | - | mA |
| Output Current (Sink) | IOL15 | VDD = 15V, VOUT = 1.5V | 1, 2 | +125 ⁰ C | 2.4 | - | mA |
| | | | | -55 ⁰ C | 4.2 | - | mA |
| Output Current (Source) | IOH5A | VDD = 5V, VOUT = 4.6V | 1, 2 | +125 ^o C | - | -0.36 | mA |
| | | | | -55 ⁰ C | - | -0.64 | mA |

TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS (Continued)

| | | | | | LIN | IITS | |
|--------------------------|----------------|-------------------------------|------------|--------------------------|-----|-------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | TEMPERATURE | MIN | MAX | UNITS |
| Output Current (Source) | IOH5B | VDD = 5V, VOUT = 2.5V | 1, 2 | +125 ⁰ C | - | -1.15 | mA |
| | | | | -55 ⁰ C | - | -2.0 | mA |
| Output Current (Source) | IOH10 | VDD = 10V, VOUT = 9.5V | 1, 2 | +125 ^o C | - | -0.9 | mA |
| | | | | -55 ⁰ C | - | -1.6 | mA |
| Output Current (Source) | IOH15 | VDD =15V, VOUT = 13.5V | 1, 2 | +125 ⁰ C | - | -2.4 | mA |
| | | | | -55 ^o C | - | -4.2 | mA |
| Input Voltage Low | VIL | VDD = 10V, VOH > 9V, VOL < 1V | 1, 2 | +25°C, +125°C, - 55°C | - | 3 | V |
| Input Voltage High | VIH | VDD = 10V, VOH > 9V, VOL < 1V | 1, 2 | +25°C, +125°C, - 55°C | +7 | - | V |
| Propagation Delay | TPHL1 | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 200 | ns |
| Clock to Q Output | TPLH1 | VDD = 15V | 1, 2, 3 | +25°C | - | 150 | ns |
| Propagation Delay | TPHL2 | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 210 | ns |
| Preset or Reset to Q | TPLH2 | VDD = 15V | 1, 2, 3 | +25 ^o C | - | 160 | ns |
| Propagation Delay | TPHL3 | VDD = 10V | 1, 2, 3 | +25°C | - | 240 | ns |
| Clock to Carry Out | TPLH3 | VDD = 15V | 1, 2, 3 | +25 ^o C | - | 180 | ns |
| Propagation Delay | TPHL4 | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 120 | ns |
| Carry In to Carry Out | TPLH4 | VDD = 15V | 1, 2, 3 | +25°C | - | 100 | ns |
| Propagation Delay Preset | TPHL5 TPLH5 | VDD = 10V | 1, 2, 3, 4 | +25 ^o C | - | 320 | ns |
| or Reset to Carry Out | | VDD = 15V | 1, 2, 3, 4 | +25 ^o C | - | 250 | ns |
| Transition Time | TTLH | VDD = 10V | 1, 2, 3 | +25°C | - | 100 | ns |
| | TTHL | VDD = 15V | 1, 2, 3 | +25 ^o C | - | 80 | ns |
| Maximum Clock Input Fre- | FCL | VDD = 10V | 1, 2 | +25 ^o C | 4 | - | MHz |
| quency | | VDD = 15V | 1, 2 | +25 ^o C | 5.5 | - | MHz |
| Minimum Hold Time | TH | VDD = 5V | 1, 2, 3 | +25 ^o C | - | 70 | ns |
| Preset Enable to JN | | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 40 | ns |
| | | VDD = 15V | 1, 2, 3 | +25°C | - | 40 | ns |
| Minimum Data Setup Time | TS | VDD = 5V | 1, 2, 3 | +25°C | - | 25 | ns |
| Preset Enable to JN | | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 10 | ns |
| | | VDD = 15V | 1, 2, 3 | +25 ^o C | - | 10 | ns |
| Minimum Data Hold Time | TH | VDD = 5V | 1, 2, 3 | +25 ^o C | - | 60 | ns |
| Clock to Carry In | | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 30 | ns |
| | | VDD = 15V | 1, 2, 3 | +25°C | - | 30 | ns |
| Minimum Clock Hold Time | TH | VDD = 5V | 1, 2, 3 | +25 ^o C | - | 30 | ns |
| Clock to Up/Down | | VDD = 10V | 1, 2, 3 | +25 ^o C | - | 30 | ns |
| | | VDD = 15V | 1, 2, 3 | +25°C | - | 30 | ns |
| Input Capacitance | CIN | Any Input | 1, 2 | +25 ^o C | - | 7.5 | pF |

NOTES:

- 1. All voltages referenced to device GND.
- 2. The parameters listed on Table 3 are controlled via design or process and are not directly tested. These parameters are characterized on initial design release and upon design changes which would affect these characteristics.
- 3. CL = 50pF, RL = 200K, Input TR, TF < 20ns.
- 4. Reset to Carry Out (TPLH) only.

TABLE 4. POST IRRADIATION ELECTRICAL PERFORMANCE CHARACTERISTICS

| | | | | LIM | | | |
|------------------------------|--------------|---|------------|--------------------|----------------|---------------------------------------|-------|
| PARAMETER | SYMBOL | CONDITIONS | NOTES | NOTES TEMPERATURE | | MAX | UNITS |
| Supply Current | IDD | VDD = 20V, VIN = VDD or GND | 1, 4 | +25 ^o C | - | 25 | μΑ |
| N Threshold Voltage | VNTH | VDD = 10V, ISS = -10μA | 1, 4 | +25°C | -2.8 | -0.2 | V |
| N Threshold Voltage Delta | ΔVTN | VDD = 10V, ISS = -10μA | 1, 4 | +25°C | - | ±1 | V |
| P Threshold Voltage | VTP | VSS = 0V, IDD = 10μA | 1, 4 | +25 ^o C | 0.2 | 2.8 | V |
| P Threshold Voltage Delta | ΔVTP | VSS = 0V, IDD = 10μA | 1, 4 | +25°C | - | ±1 | V |
| Functional | F | VDD = 18V, VIN = VDD or GND VDD = 3V, VIN = VDD or GND | 1 | +25 ^o C | VOH > VDD/2 | VOL < VDD/2 | V |
| Propagation Delay Time | TPHL TPLH | VDD = 5V | 1, 2, 3, 4 | +25°C | - | 1.35 x +25 ^o C Limit | ns |

NOTES: 1. All voltages referenced to device GND.

3. See Table 2 for +25°C limit.

2. CL = 50pF, RL = 200K, Input TR, TF < 20ns.

4. Read and Record

TABLE 5. BURN-IN AND LIFE TEST DELTA PARAMETERS +25°C

| PARAMETER | SYMBOL | DELTA LIMIT |
|-------------------------|--------|--------------------------|
| Supply Current - MSI-2 | IDD | ± 1.0μA |
| Output Current (Sink) | IOL5 | ± 20% x Pre-Test Reading |
| Output Current (Source) | IOH5A | ± 20% x Pre-Test Reading |

TABLE 6. APPLICABLE SUBGROUPS

| CONFORMANCE GROUP | | MIL-STD-883 METHOD | GROUP A SUBGROUPS | READ AND RECORD |
|-------------------------------|---------------|-----------------------|---------------------------------------|------------------------------|
| Initial Test (Pre | Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| Interim Test 1 (F | Post Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| Interim Test 2 (F | Post Burn-In) | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| PDA (Note 1) | | 100% 5004 | 1, 7, 9, Deltas | |
| Interim Test 3 (Post Burn-In) | | 100% 5004 | 1, 7, 9 | IDD, IOL5, IOH5A |
| PDA (Note 1) | | 100% 5004 | 1, 7, 9, Deltas | |
| Final Test | | 100% 5004 | 2, 3, 8A, 8B, 10, 11 | |
| Group A | | Sample 5005 | 1, 2, 3, 7, 8A, 8B, 9, 10, 11 | |
| Group B | Subgroup B-5 | Sample 5005 | 1, 2, 3, 7, 8A, 8B, 9, 10, 11, Deltas | Subgroups 1, 2, 3, 9, 10, 11 |
| Subgroup B-6 | | Sample 5005 | 1, 7, 9 | |
| Group D | | Sample 5005 | 1, 2, 3, 8A, 8B, 9 | Subgroups 1, 2 3 |

NOTE: 1.5% Parameteric, 3% Functional; Cumulative for Static 1 and 2.

TABLE 7. TOTAL DOSE IRRADIATION

| | MIL-STD-883 | TE | ST | READ AND | O RECORD |
|--------------------|-------------|-----------|------------|-----------|------------|
| CONFORMANCE GROUPS | METHOD | PRE-IRRAD | POST-IRRAD | PRE-IRRAD | POST-IRRAD |
| Group E Subgroup 2 | 5005 | 1, 7, 9 | Table 4 | 1, 9 | Table 4 |

TABLE 8. BURN-IN AND IRRADIATION TEST CONNECTIONS

| | | | | | OSCILLATOR | |
|------------------------------|-----------------|-----------------------------|----------------------------------|-----------------|------------|-------|
| FUNCTION | OPEN | GROUND | VDD | 9V \pm -0.5V | 50kHz | 25kHz |
| CD4510BMS | | - | | | | |
| Static Burn-In 1 (Note 1) | 2, 6, 7, 11, 14 | 1, 3-5, 8-10, 12, 13, 15 | 16 | | | |
| Static Burn-In 2 (Note 1) | 2, 6, 7, 11, 14 | 8 | 1, 3-5, 9, 10, 12, 13, 15, 16 | | | |
| Dynamic Burn- In (Note 1) | - | 1, 3, 4, 8, 9, 12, 13 | 10, 16 | 2, 6, 7, 11, 14 | 15 | 5 |
| Irradiation (Note 2) | 2, 6, 7, 11, 14 | 8 | 1, 3-5, 9, 10, 12, 13, 15, 16 | | | |

NOTES:

- 1. Each pin except VDD and GND will have a series resistor of 10K \pm 5%, VDD = 18V \pm 0.5V
- 2. Each pin except VDD and GND will have a series resistor of 47K \pm 5%; Group E, Subgroup 2, sample size is 4 dice/wafer, 0 failures, VDD = $10V \pm 0.5V$

Logic Diagrams

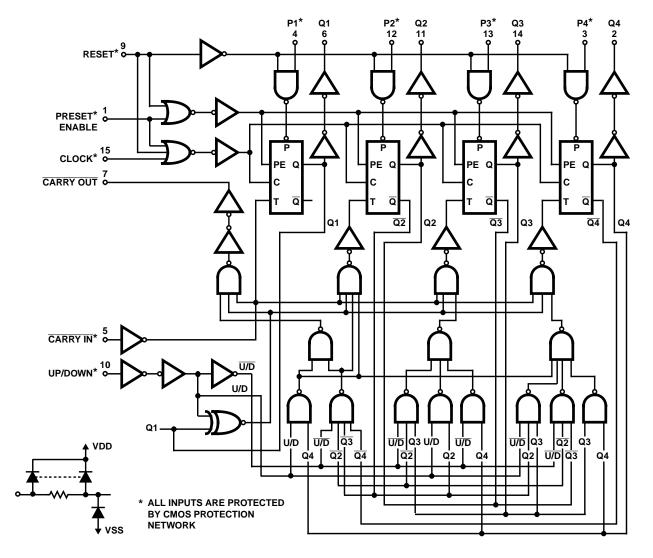


FIGURE 1. CD4510BMS

Logic Diagrams (Continued)

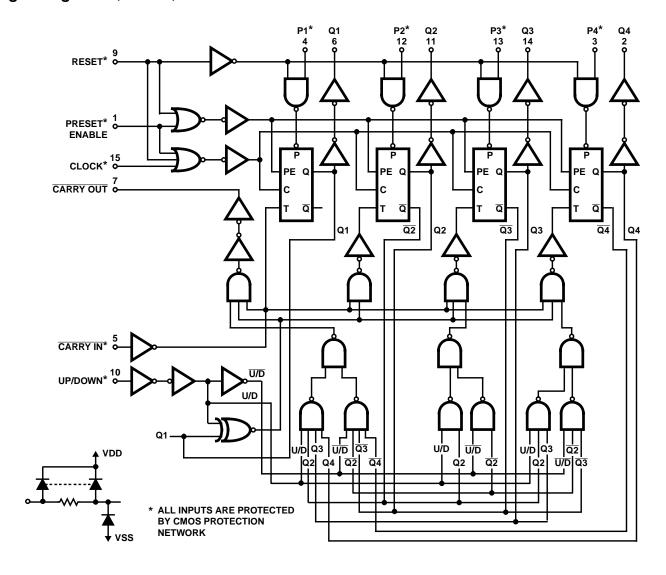


FIGURE 2. CD4516BMS

TRUTH TABLE

| CL | CI | U/D | PE | R | ACTION |
|----|----|-----|----|---|------------|
| Х | 1 | X | 0 | 0 | NO COUNT |
| | 0 | 1 | 0 | 0 | COUNT UP |
| | 0 | 0 | 0 | 0 | COUNT DOWN |
| Х | Х | Х | 1 | 0 | PRESET |
| Х | X | X | X | 1 | RESET |

X = DON'T CARE

Typical Performance Characteristics

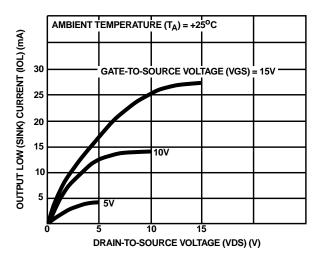


FIGURE 3. TYPICAL OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

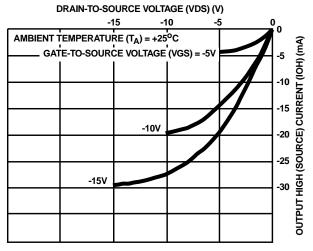


FIGURE 5. TYPICAL OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

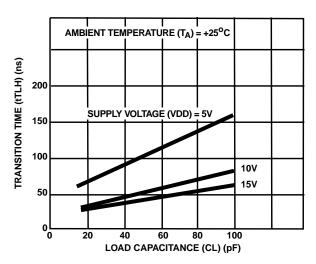


FIGURE 7. TYPICAL TRANSITION TIME vs LOAD CAPACITANCE

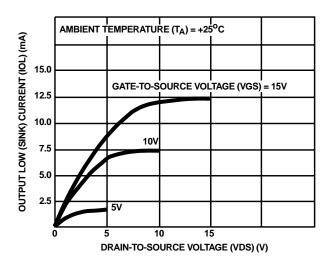


FIGURE 4. MINIMUM OUTPUT LOW (SINK) CURRENT CHARACTERISTICS

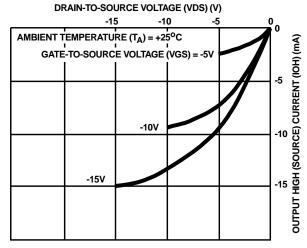


FIGURE 6. MINIMUM OUTPUT HIGH (SOURCE) CURRENT CHARACTERISTICS

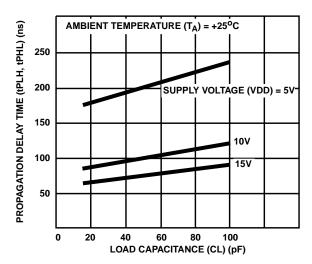
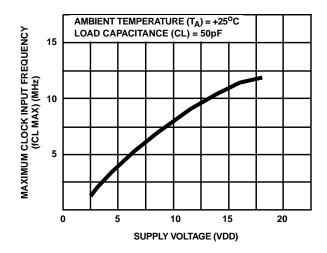


FIGURE 8. TYPICAL PROPAGATION DELAY TIME vs LOAD CAPACITANCE FOR CLOCK-TO-Q OUTPUTS

Typical Performance Characteristics (Continued)



10⁴ AMBIENT TEMPERATURE (TA) POWER DISSIPATION PER GATE (PD) (µW) = +25°C VOLTS (VDD) 10³ 10² CL = 50pF CL = 15pF ** 10 4 6 8 4 6 8 10³ 10² 01 10⁴ 10 INPUT FREQUENCY (fCL) (kHz)

FIGURE 9. TYPICAL MAXIMUM CLOCK INPUT FREQUENCY vs SUPPLY VOLTAGE

FIGURE 10. TYPICAL DYNAMIC POWER DISSIPATION vs FREQUENCY

vss

Test Circuit and Waveform

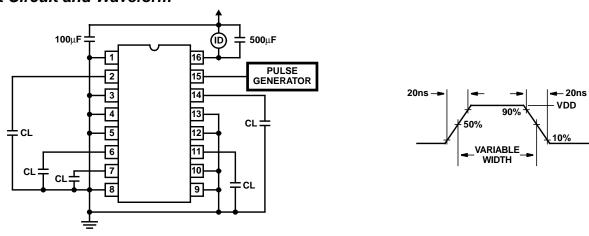


FIGURE 11. POWER DISSIPATION TEST CIRCUIT AND INPUT WAVEFORM

Acquisition System

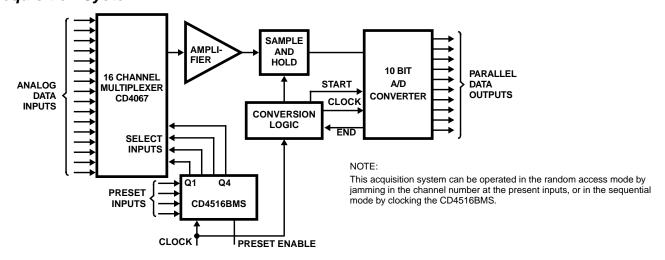


FIGURE 12. TYPICAL 16 CHANNEL, 10 BIT DATA ACQUISITION SYSTEM

Timing Diagrams

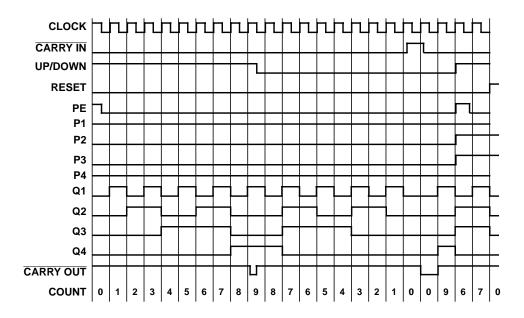


FIGURE 13. CD4510BMS

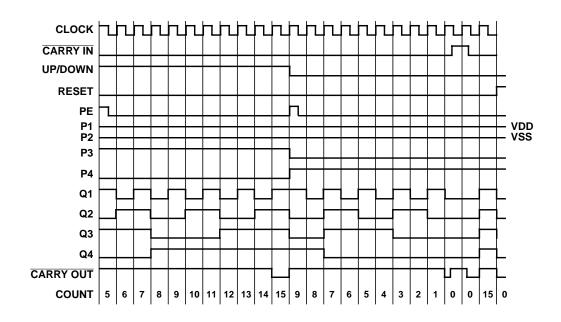
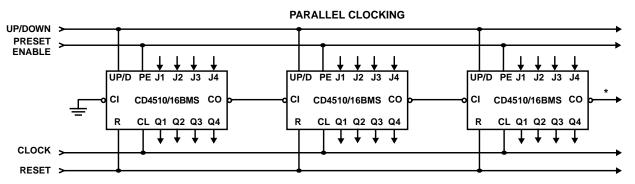
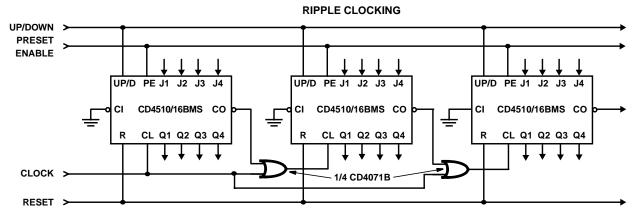


FIGURE 14. CD4516BMS



* CARRY OUT lines at the 2nd, 3rd, etc., stages may have a negative-going glitch pulse resulting from differential delays of different CD4010/16BMS IC'S. These negative going glitches do not affect proper CD4029BMS operation. However, if the CARRY OUT signals are used to trigger other edge-sensitive logic devices, such as FF'S or counters, the CARRY OUT signals should be gated with the clock signal using a 2-input OR gate such as CD4071BMS.



Ripple Clocking Mode: The up/down control can be changed at any count. The only restriction on changing the up/down control is that the clock input to the first counting stage must be high. For cascading counters operating in a fixed up-count or down-count mode, the OR gates are not required between stages, and CO is connected directly to the CL input of the next stage with CI grounded.

FIGURE 15. CASCADING COUNTER PACKAGES

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